

规格书编号

**SPEC NO:** 

# 产品规格书 SPECIFICATION

CUSTOMER 客 户:						
PRODUCT 产品:	SAW FILTER					
MODEL NO 型 号:	HDF868A-F11					
PREPARED 编 制:	CHECKED 审 核:					
APPROVED 批准:	DATE 日期	: 2006-5-11				
客户确认 CUSTOMER RECEIVED:						
审核 CHECKED	批准 APPROVED	日期 DATE				

无锡市好达电子有限公司 Shoulder Electronics Limited





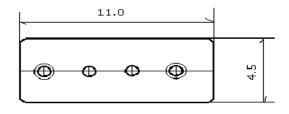
# 更改历史记录 History Record

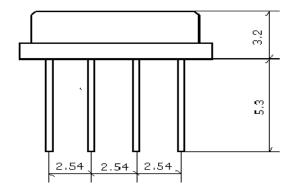
更改日期 Date	规格书编号 Spec. No.	产品型号 Part No.	客户产品型号 Customer No.	更改内容描述 Modify Content	备注 Remark

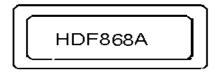


# 1. Package Dimension

Unit:mm







# 2. Marking HD F868A

2.1 Color: Black or Blue

2.2 868.: Center Frequency(MHz)

## 3.Performance

#### 3.1Application

Low-Loss SAW Filter of cordless system.

Center Frequency:868 MHz

#### 3.2Maximum Rating

Operation Temperature Range	-40°C to +85°C	
Storage Temperature Range	-40°C to +85°C	
DC. Permissive Voltage	0 V DC. max.	
Maximum Input Power	11dBm	

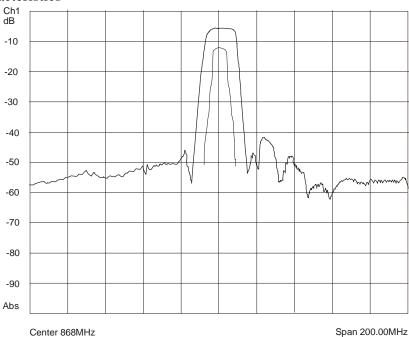


SAW FILTER HDF868A-F11

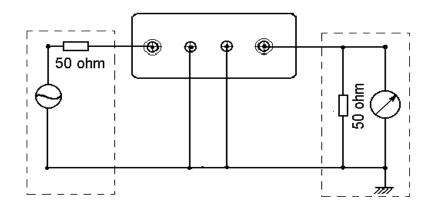
#### 3.3 Electronic Characteristics

Item	Frequency	Specification
Center Frequency(fo)	868MHz	
Pass Band Width	Fo±2.0MHz	
Insertion Loss	Passband	4.5dB max.
Stop Band Rejection	Fo-400~-40.8MHz	47dB min.
	Fo+50~+400MHz	40dB min.
Terminating Impedance		50 Ω //<10nH
Operating Temperature Range		-10°C To +70°C

## 3.4 Frequency Characteristics



# 4. Test Circuit





**SAW FILTER** 

### 5.ENVIRONMENTAL CHARACTERISTICS

#### 5-1 High temperature exposure

Subject the device to  $+85^{\circ}$ C for 16 hours. Then release the filter into the room conditions for 24 hours prior to the measurement. It shall fulfill the specifications in 3.3.

#### 5-2 Low temperature exposure

Subject the device to  $-40^{\circ}$ C for 16 hours. Then release the device into the room conditions for 24 hours prior to the measurement. It shall fulfill the specifications in 3.3.

#### 5-3 Temperature cycling

Subject the device to a low temperature of  $-40^{\circ}$ C for 30 minutes. Following by a high temperature of  $+85^{\circ}$ C for 30 Minutes. Then release the device into the room conditions for 24 hours prior to the measurement. It shall meet the specifications in 3.3.

#### 5-4 Resistance to solder heat

Dip the device terminals no closer than 1.5mm into the solder bath at  $260^{\circ}$ C  $\pm 10^{\circ}$ C for  $10\pm 1$  sec. Then release the device into the room conditions for 4 hours. The device shall meet the specifications in 3.3.

#### 5-5 Solderability

Subject the device terminals into the solder bath at  $245^{\circ}$ C  $\pm 5^{\circ}$ C for 5s, More than 95% area of the terminals must be covered with new solder. It shall meet the specifications in 3.3.

#### 5-6 Mechanical shock

Drop the device randomly onto the concrete floor from the height of 1m 3 times. the device shall fulfill the specifications in 3.3.

#### 5-7 Vibration

Subject the device to the vibration for 1 hour each in x,y and z axes with the amplitude of 1.5 mm at 10 to 55 Hz. The device shall fulfill the specifications in 3.3.

#### 6. REMARK

#### 6.1 Static voltage

Static voltage between signal load & ground may cause deterioration &destruction of the component. Please avoid static voltage.

#### 6.2 Ultrasonic cleaning

Ultrasonic vibration may cause deterioration & destruction of the component. Please avoid ultrasonic cleaning

#### 6.3 Soldering

Only leads of component may be soldered. Please avoid soldering another part of component.